

**Search Notes**

Application/Control No.

09/933,492

Examiner

Chris C. Chu

Applicant(s)/Patent under  
Reexamination

HEMBREE ET AL.

Art Unit

2815

**SEARCHED**

Class	Subclass	Date	Examiner
438	128 - 132	1/21/2005	C.C.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM-TDB; and USOCR;	1/21/2005	C.C.